

Notice of References Cited	Application/Control No. 10/693,171	Applicant(s)/Patent Under Reexamination KETCHUM ET AL.	
	Examiner Lawrence B. Williams	Art Unit 2634	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,771,706 B2	08-2004	Ling et al.	375/267
	B	US-6,738,020 B1	05-2004	Lindskog et al.	342/377
	C	US-6,452,981 B1	09-2002	Raleigh et al.	375/299
	D	US-2002/0034263 A1	03-2002	Schmidl et al.	375/299
	E	US-2003/0043929 A1	03-2003	Sampath, Hemanth	375/267
	F	US-6,888,899 B2	05-2005	Raleigh et al.	375/299
	G	US-2004/0095907 A1	05-2004	Agee et al.	370/334
	H	US-2002/0154705 A1	10-2002	Walton et al.	375/267
	I	US-2004/0087324 A1	05-2004	Ketchum et al.	455/513
	J	US-2004/0179627 A1	09-2004	Ketchum et al.	375/267
	K	US-2005/0111599 A1	05-2005	Walton et al.	375/347
	L	US-2004/0082356 A1	04-2004	Walton et al.	455/522
	M	US-6,668,161 B2	12-2003	Boros et al.	455/67.14

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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